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P-Channel 30 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I _D ^a	Q _g (Typ.)
	0.0065 at V _{GS} = - 10 V	- 29	
- 30	$0.0082 \text{ at V}_{GS} = -6 \text{ V}$	- 23	66 nC
	0.0112 at V _{GS} = - 4.5 V	- 20	

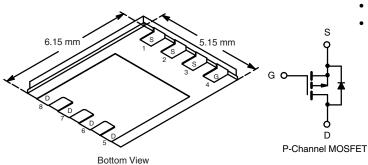
FEATURES

- Extended V_{GS} range (± 25 V) for adaptor switch applications
- Extremely low R_{DS(on)}
- TrenchFET® Power MOSFET
- 100 % R_q and UIS Tested
- Typical ESD Performance: 4000 V (HBM)



ROHS COMPLIANT HALOGEN FREE

PowerPAK SO-8



APPLICATIONS

- · Adaptor Switch, Load Switch
 - Power Management

 Notebook Computers and Portable
 Battery Packs

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 25		
	T _C = 25 °C		- 25.8		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	1_	- 20.7		
Continuous Diam Curient (1) = 130 C)	T _A = 25 °C	- I _D	- 17.3		
	T _A = 70 °C		- 13.9 ^{b, c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 60		
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	- 5.8 ^{b, c}		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	- 2.6 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 40		
Single Pulse Avalanche Energy	L = U. I IIII	E _{AS}	80	mJ	
	T _C = 25 °C		6.9		
Maximum Power Dissipation	T _C = 70 °C	P _D	4.4	w	
Maximum Fower Dissipation	T _A = 25 °C	I D	3.1 ^{b, c}	VV	
	T _A = 70 °C		2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RA	ERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	33	40	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	15	17	J/ 11	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c = 10 s
- d. Maximum under steady state conditions is 90 °C/W.



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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					L	
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		- 24		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		6		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	- 1.2		- 2.8	V
Oaks Oassaa Laaksaa	1	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			± 150	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 15	1
Zero Osto Vellana Busin Ouront	,	V _{DS} = - 30 V, V _{GS} = 0 V			- 1	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10	1
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α
		V _{GS} = - 10 V, I _D = - 13 A	0.0054 0.006		0.0065	-
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 6 V, I _D = - 10 A		0.0068	0.0082	Ω
	, ,	V _{GS} = - 4.5 V, I _D = - 8 A		0.0093	0.0112	
Forward Transconductance ^a				44		S
Dynamic ^b				l	l	
Input Capacitance	C _{iss}			4620		pF
Output Capacitance	C _{oss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		880		
Reverse Transfer Capacitance	C _{rss}			820		1
Total Cata Charge	Q_g	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -17.3 \text{ A}$		102	153	nC
Total Gate Charge				66	80	
Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -5 \text{ V}, I_{D} = -17.3 \text{ A}$		16		
Gate-Drain Charge	Q_{gd}			28		
Gate Resistance	R_g	f = 1 MHz	0.3	1.3	2.6	Ω
Turn-On Delay Time	t _{d(on)}			70	105	
Rise Time	t _r	V_{DD} = 0 V, R_L = 1.5 Ω		70	105	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		45	68	
Fall Time	t _f			27	41	ne
Turn-On Delay Time	t _{d(on)}			18	30	ns
Rise Time	t _r	V_{DD} = - 15 V, R_L = 1.5 Ω		15	25	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 10 A, V_GEN = - 10 V, R_g = 1 Ω		52	80	
Fall Time	t _f			14	25	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 5.8	Α
Pulse Diode Forward Current	I _{SM}				- 60	
Body Diode Voltage	V_{SD}	$I_S = -10 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.78	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			35	53	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 10 A, dI/dt = 100 A/μs, T _J = 25 °C		25	38	nC
Reverse Recovery Fall Time	t _a	107, απαι - 100 π/μο, 11 - 20 0		19		ns
Reverse Recovery Rise Time	t _b			16		

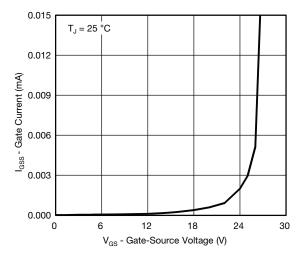
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

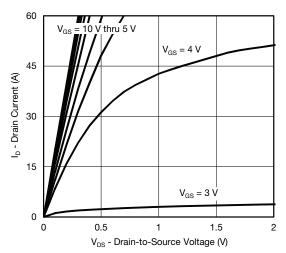
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$

b. Guaranteed by design, not subject to production testing.

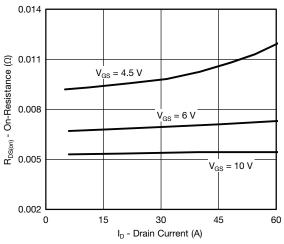




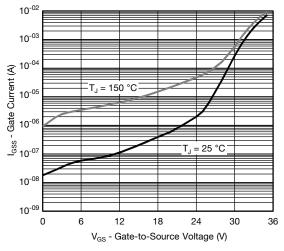
Gate Current vs. Gate-Source Voltage



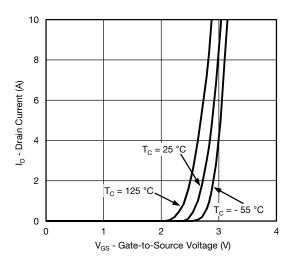
Output Characteristics



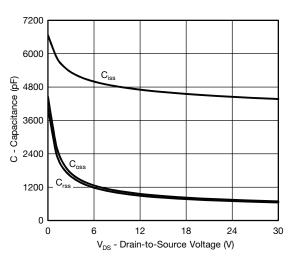
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage

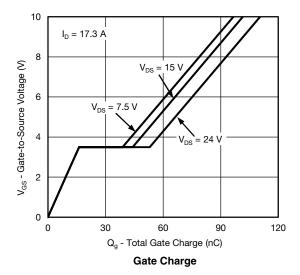


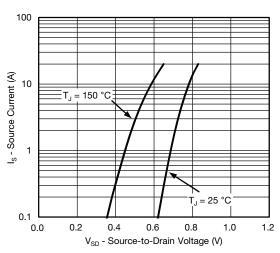
Transfer Characteristics



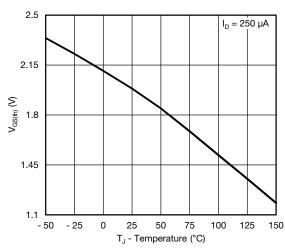
Capacitance



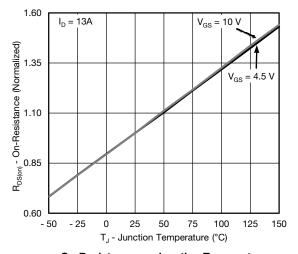




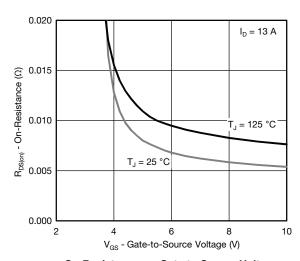
Source-Drain Diode Forward Voltage



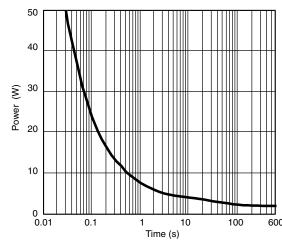
Threshold Voltage



On-Resistance vs. Junction Temperature

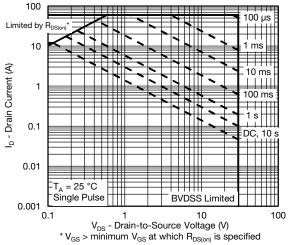


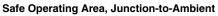
On-Resistance vs. Gate-to-Source Voltage

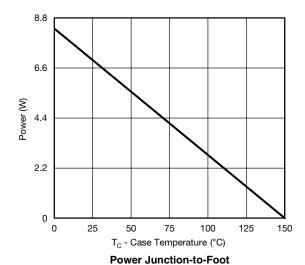


Single Pulse Power, Junction-to-Ambient



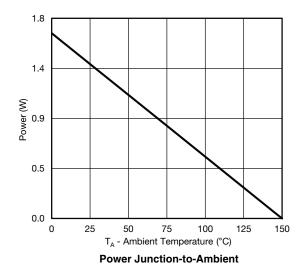






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Current Derating*

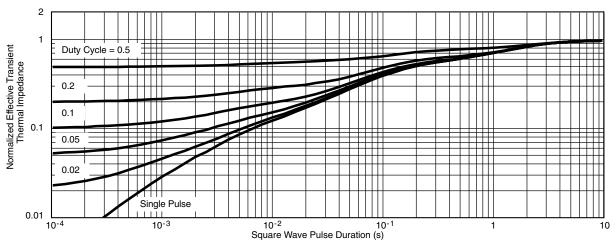


^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





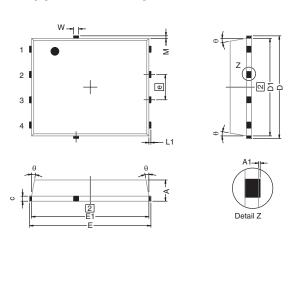
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

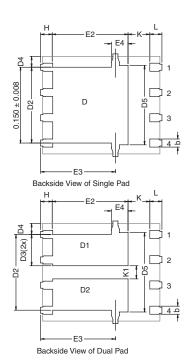


PowerPAK SO-8, (SINGLE/DUAL)



Notes

- 1. Inch will govern.
- 2 Dimensions exclusive of mold gate burrs.
- 3. Dimensions exclusive of mold flash and cutting burrs.



	MILLIMETERS			INCHES			
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.97	1.04	1.12	0.038	0.041	0.044	
A1	0.00	-	0.05	0.000	-	0.002	
b	0.33	0.41	0.51	0.013	0.016	0.020	
С	0.23	0.28	0.33	0.009	0.011	0.013	
D	5.05	5.15	5.26	0.199	0.203	0.207	
D1	4.80	4.90	5.00	0.189	0.193	0.197	
D2	3.56	3.76	3.91	0.140	0.148	0.154	
D3	1.32	1.50	1.68	0.052	0.059	0.066	
D4	0.57 TYP.			0.0225 TYP.			
D5		3.98 TYP.		0.157 TYP.			
E	6.05	6.15	6.25	0.238	0.242	0.246	
E1	5.79	5.89	5.99	0.228	0.232	0.236	
E2	3.48	3.66	3.84	0.137	0.144	0.151	
E3	3.68	3.78	3.91	0.145	0.149	0.154	
E4		0.75 TYP.			0.030 TYP.		
е	1.27 BSC			0.050 BSC			
K		1.27 TYP.		0.050 TYP.			
K1	0.56	-	-	0.022	-	-	
Н	0.51	0.61	0.71	0.020	0.024	0.028	
L	0.51	0.61	0.71	0.020	0.024	0.028	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
θ	0°	-	12°	0°	-	12°	
W	0.15	0.25	0.36	0.006	0.010	0.014	
М	0.125 TYP.			0.005 TYP.			

DWG: 5881



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